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# **Enhancing the Security of Smart Grid Networks**

Guest Editors:

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Deadline for manuscript submissions:

closed (31 July 2023)

### **Message from the Guest Editors**

this Special Issue will invite and collect security/risk detection, analysis, assessment technology, authentication, secure data transmission and privacy preservation technologies related to the smart grid networks.

Potential topics include, but are not limited to, the following:

- Risk analysis and assessment technology in smart grid networks;
- Access to security detection technology for service terminals in smart grid networks;
- Edge equipment security detection technology in smart grid networks;
- Network transmission security detection technology in smart grid networks;
- Security detection tools in smart grid networks;
- New access authentication protocols with privacy preservation for smart grid networks;
- Authentication and privacy protection for smart grid networks;
- Slicing security and privacy protection for smart grid networks;
- End-to-end security for smart grid networks;
- Physical layer security for smart grid networks;
- Artificial Intelligence and Machine Learning for smart grid networks.

Welcome to contribute.

Specialsue









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### **Editor-in-Chief**

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## **Message from the Editor-in-Chief**

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